## Notice of References Cited Application/Control No. 10/734,448 Examiner Jermele M. Hollington Applicant(s)/Patent Under Reexamination TRAN ET AL. Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,180,971 A	01-1993	Montijo, B. Allen	324/121R
	В	US-6,060,878 A	05-2000	Doi, Wataru	324/76.27
	O	US-6,121,799 A	09-2000	Moser, Michael F.	327/58
	D	US-6,812,688 B2	11-2004	Tan et al.	324/121R
	Е	US-2003/0220753 A1	11-2003	Pickerd et al.	702/67
	F	US-2003/0231187 A1	12-2003	Dobyns et al.	345/619
	G	US-2004/0013176 A1	01-2004	Gerlach et al.	375/211
	Н	US-2004/0117138 A1	06-2004	Tran et al.	702/066
	l	US-2004/0117143 A1	06-2004	Tran et al.	702/121
	J	US-2004/0119620 A1	06-2004	Tran et al.	341/126
	К	US-2004/0174818 A1	09-2004	Zocchi, Donald A.	370/241
	L	US-6,832,174	12-2004	Tran et al.	324/76.38
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	O					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.